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## APPLICANTS

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\*\* CONTINUING DATA .....none pme

\*\* FOREIGN APPLICATIONS .....yes pme  
JAPAN 2003-036125 02/14/2003IF REQUIRED, FOREIGN FILING LICENSE GRANTED  
\*\* 04/27/2004

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	STATE OR COUNTRY JAPAN	SHEETS DRAWING 19	TOTAL CLAIMS 18	INDEPENDENT CLAIMS 5
Verifier and Acknowledged Examiner's Signature _____ Initials _____					

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## TITLE

Semiconductor testing circuit, semiconductor storage device, and semiconductor testing method

FILING FEE RECEIVED 942	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue )
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